## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | KANNO ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0138643	09-2002	Shin et al.	709/232
*	В	US-6,986,139	01-2006	Kubo, Hidehito	718/105
*	O	US-7,107,619	09-2006	Silverman, Robert M.	726/27
*	D	US-7,124,438	10-2006	Judge et al.	726/22
*	E	US-6,751,668	06-2004	Lin et al.	709/227
*	F	US-6,212,640	04-2001	Abdelnur et al.	726/2
*	G	US-2002/0138599	09-2002	Dilman et al.	709/223
*	Ξ	US-7,131,140	10-2006	O'Rourke et al.	726/11
*	ı	US-2004/0054924	03-2004	Chuah et al.	713/201
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.